

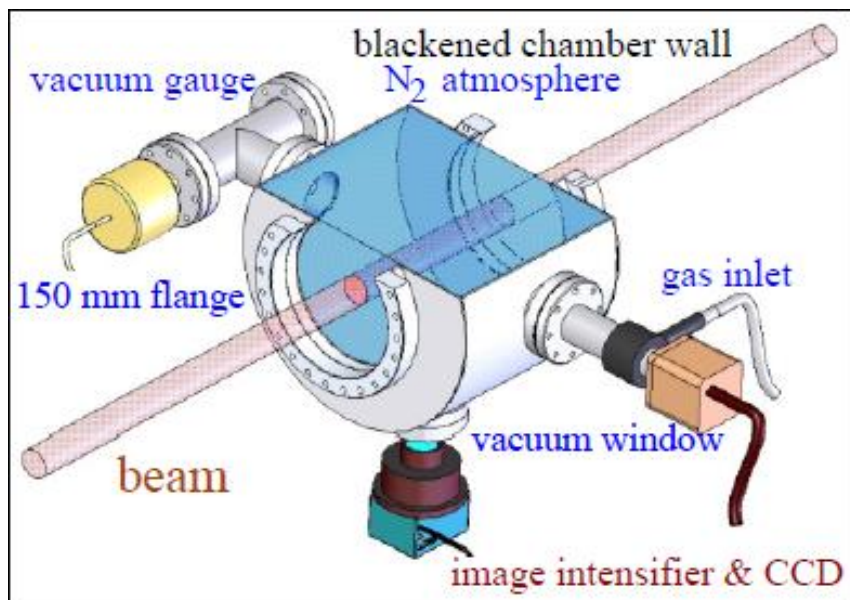
Beam Fluorescence-based Beam Diagnostic Tomography

High Intensity Proton Beam Diagnostics
workshop- September 27th

Cherry May Mateo- DITANET, CEA Saclay

Non-destructive diagnostics

Motivation



Schematic of BIF at GSI*

Increased demand

- It must not perturb the beam
- It must not be destroyed by **high current beam** (kilowatt beam power)

Optical Profilers

- Beam Induced Fluorescence (BIF) Monitor at GSI*
- Beam Ionization Optical profile monitors

*F. Becker et al., Beam Induced Fluorescence Monitor for Transverse Profile Determination of 5 to 750 MeV/u Heavy Ion Beams, Proceedings of DIPAC 2007, Venice, Italy

Objectives

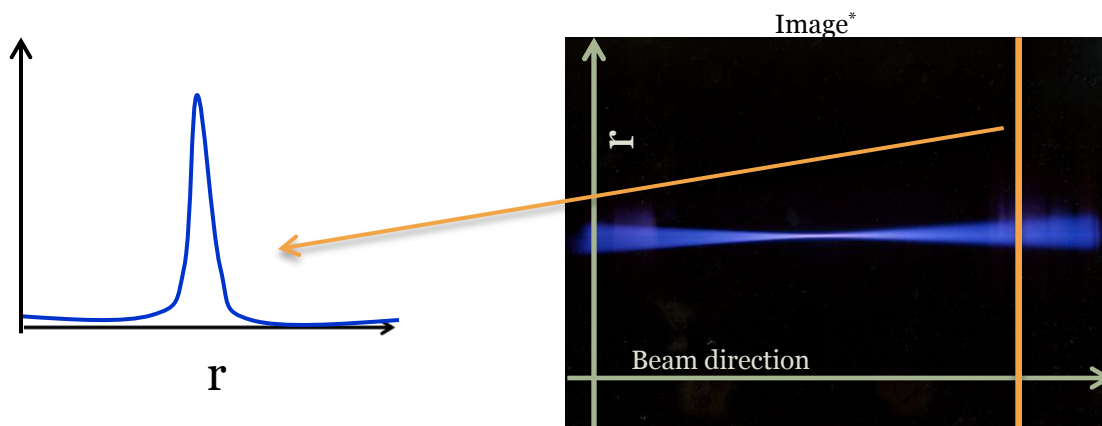
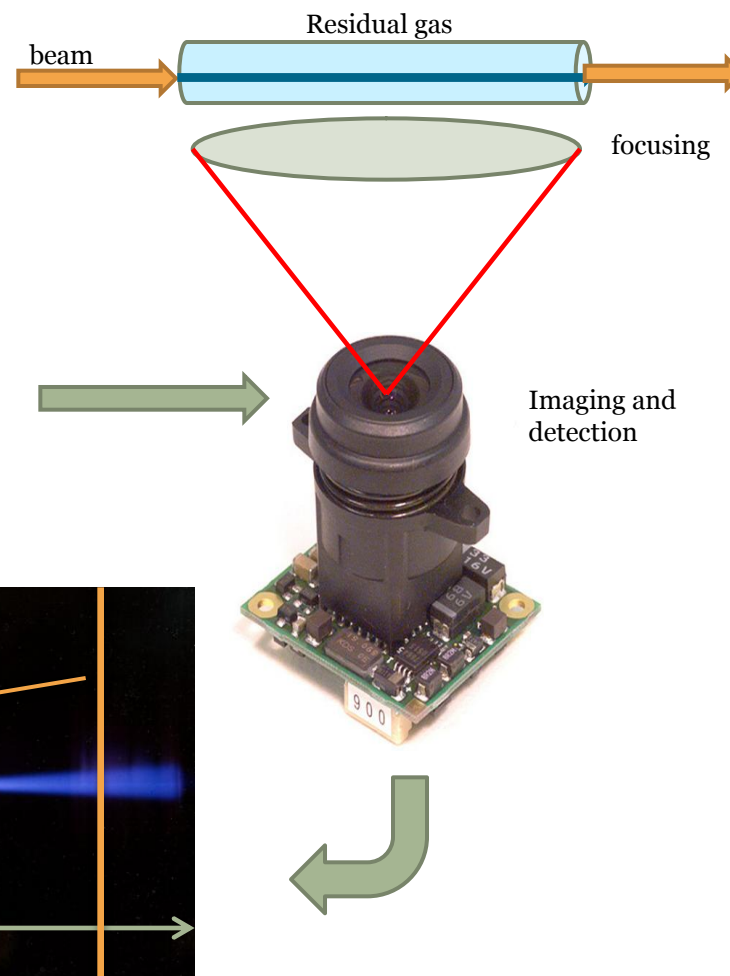
- Discuss an overview of optical profile monitors
- Demonstrate that tomographic reconstruction can be incorporated with optical profilers to reconstruct beam's spatial density.

Optical Profiler

Beam Fluorescence on residual gas

$$N_{\text{photons}} = K \cdot \Psi \cdot \rho \cdot \Delta s \cdot \sigma_{\text{rad}}$$

Radiative decay
 $h\nu$ in visible light



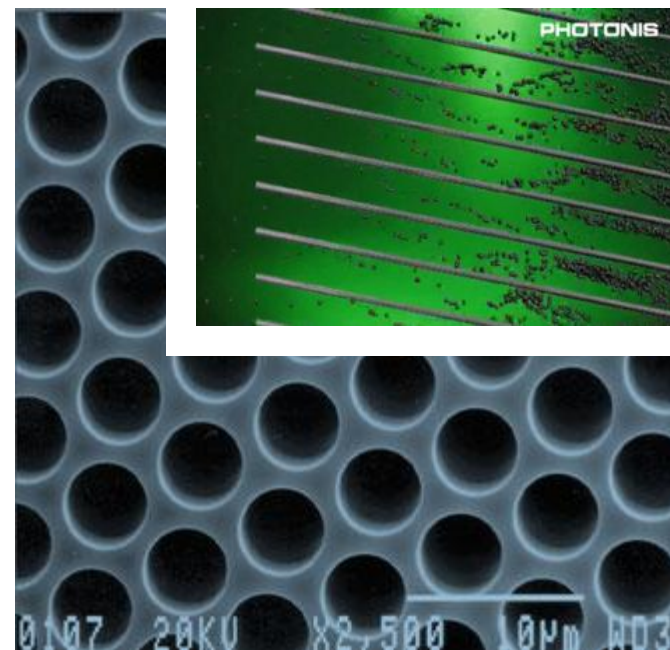
*Pottin, B, (2001) Etude d'un profileur optique de faisceaux intenses de protons par absorption laser, Doctor of Science thesis. Institut de Physique Nucléaire

Detectors

- **1D sensors**
 - Photo diodes
 - Linear CCD arrays
 - Segmented photomultiplier
- **2D sensors**
 - Area CCD arrays
 - Area CMOS
- **Photocathode-based**
 - Photomultiplier tubes
 - Image intensifiers
 - Segmented photomultiplier
- **Solid state devices**
 - APDs
 - CMOS
 - EMCCDs

Image Intensifiers

Image intensifiers convert photons into electrons, multiply them, and then convert them back into photons, maintaining spatial information.

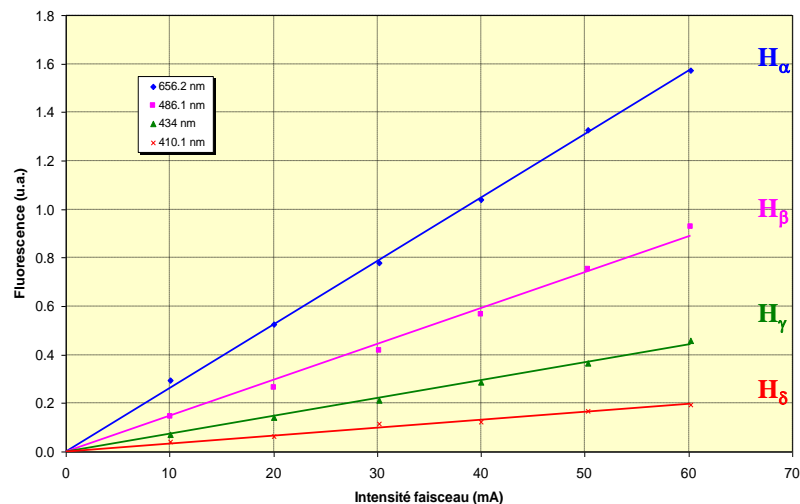
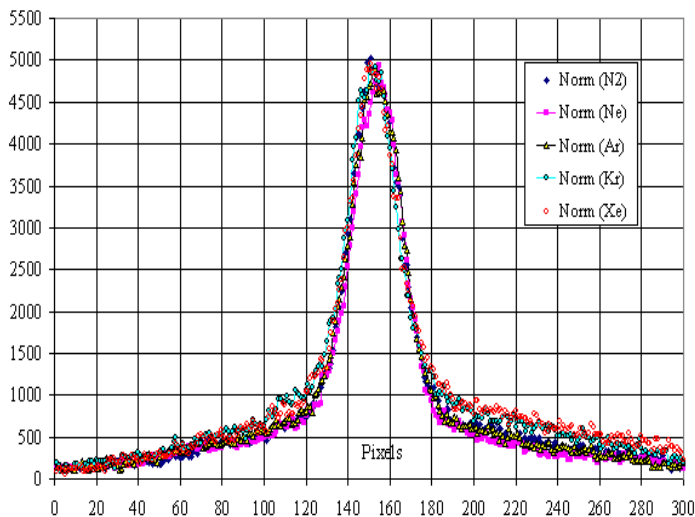


*Peter Seitz and Albert JP Theuwissen. *Single-Photon Imaging*. Heidelberg; Springer, 2011.

Optical Profiler in IPN/CEA

Beam profiles of proton beam

- ✓ Intensified CCD camera was used to capture beam image.
- ✓ No ion separation



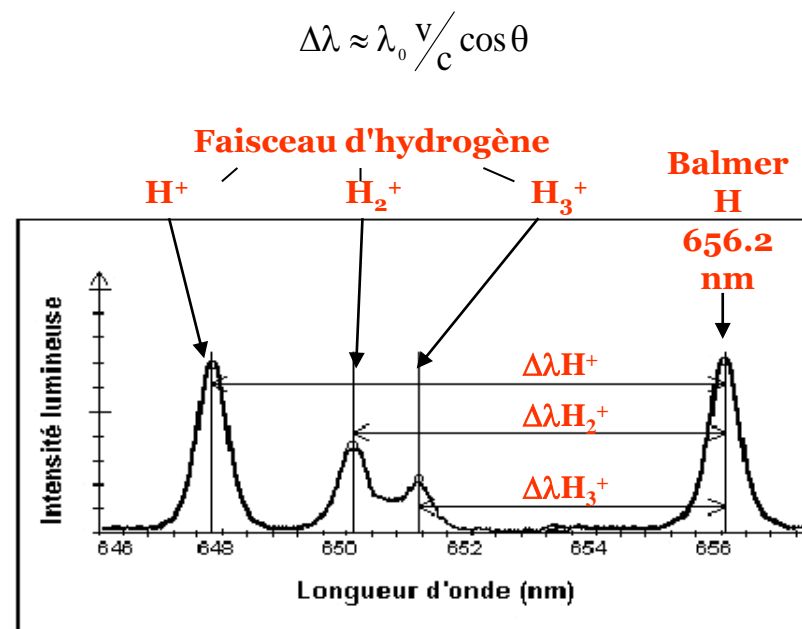
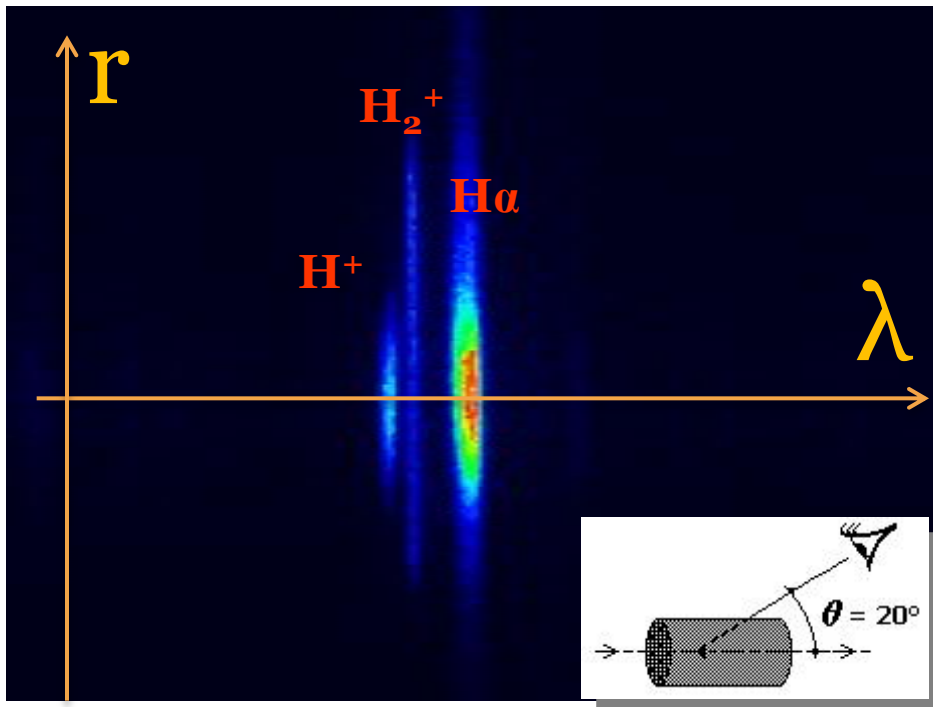
$$I_{lum} = I_{beam} \cdot \sigma \cdot n_0$$

*P. Ausset, et. al., *Transverse Beam Profile Measurements for High Power Proton Beams*, Proceedings of EPAC 2001, Paris, France

*Pottin, B. (2001) *Etude d'un profileur optique de faisceaux intenses de protons par absorption laser*, Doctor of Science thesis. Institut de Physique Nucléaire

Optical Profiler in IPN/CEA

Doppler Shift Spectroscopy allows discrimination of different beam components



*Pottin, B. (2001) Etude d'un profileur optique de faisceaux intenses de protons par absorption laser, Doctor of Science thesis. Institut de Physique Nucléaire

*P. Ausset, et. al., *Transverse Beam Profile Measurements for High Power Proton Beams*, Proceedings of EPAC 2001, Paris, France

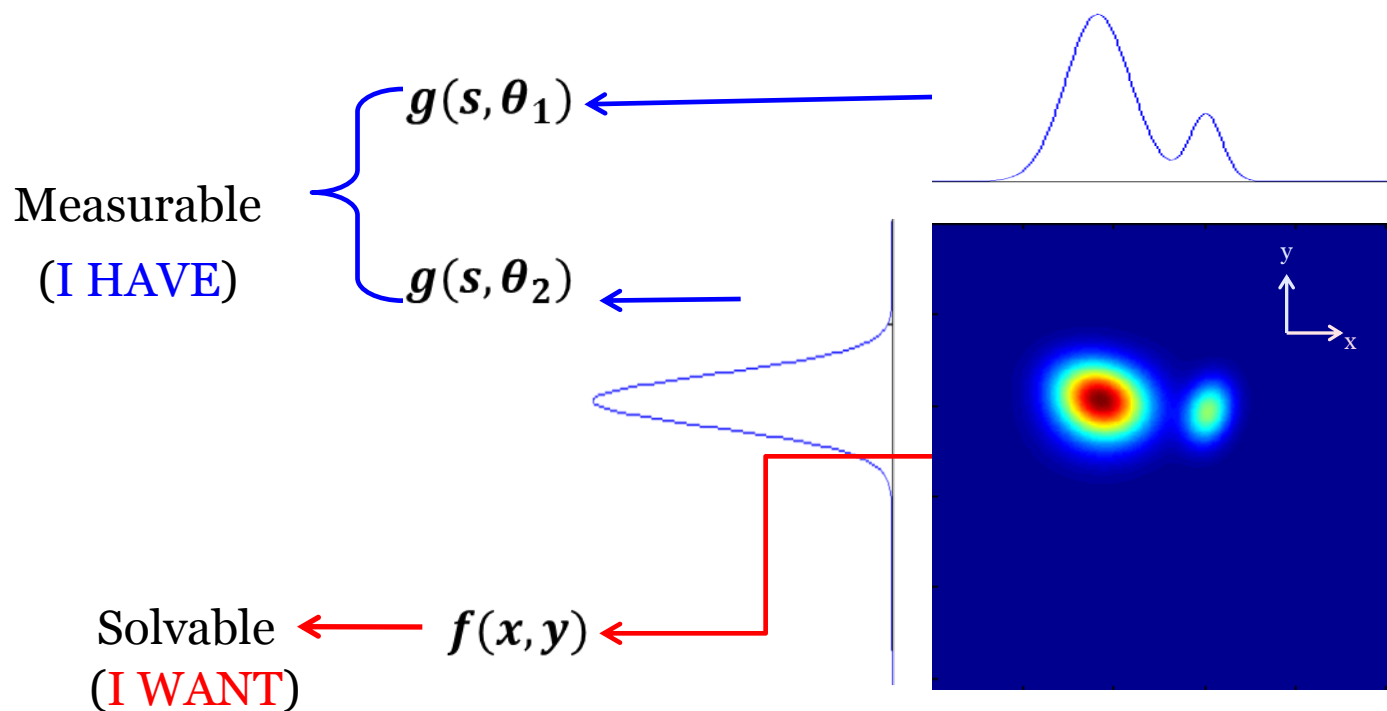
Beam fluorescence monitors allow multiple measurements of beam projections at different angles around the beam

Tomography

Has advantage when dealing with beam shapes that are more intricate.

Tomography

Tomography is the method used to reconstruct a 2D cross sectional image of an object given multiple flat scans taken from multiple angles around an object



Tomography

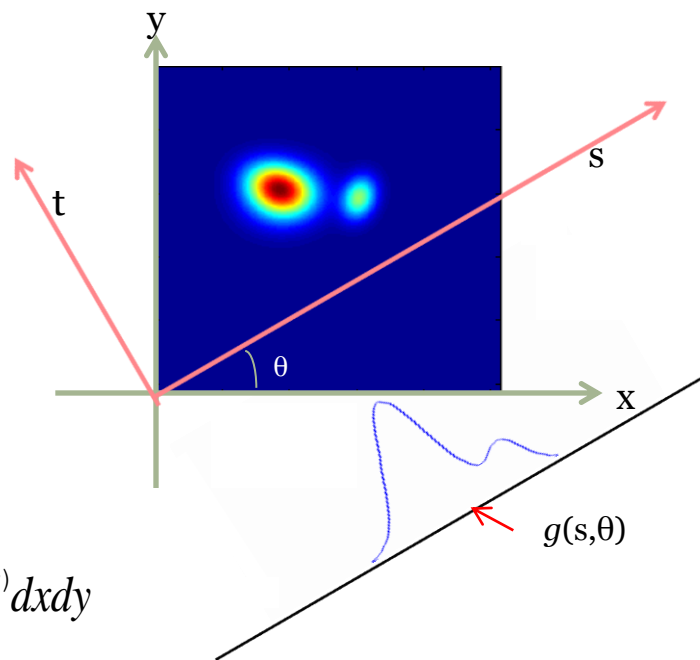
By Fourier Slice Theorem, EXACT value of $f(x,y)$ can be calculated given an infinite number of projections

$$g_n(s) = \int_{-\infty}^{+\infty} f(x_n(s, t), y_n(s, t)) dt$$

$$= \int_{-\infty}^{+\infty} f(s \cos \theta - t \sin \theta, s \sin \theta + t \cos \theta) dt$$

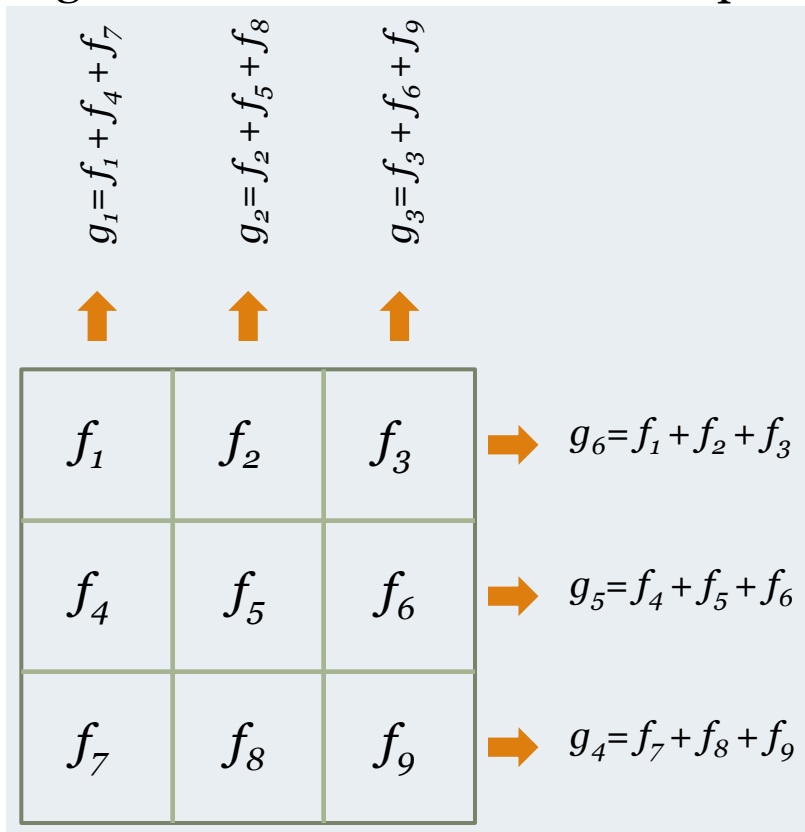
Fourier Slice theorem:

$$\int_{-\infty}^{+\infty} g(s, \theta) e^{-j2\pi vt} dt = \int_{-\infty}^{+\infty} \int_{-\infty}^{+\infty} f(x, y) e^{-j2\pi(v \cos \theta x + v \sin \theta y)} dx dy$$



How?

Algebraic Reconstruction Technique for 2 Projections



$$\begin{cases} g_1 = f_1 & + f_4 & + f_7 \\ g_2 = & f_2 & + f_5 & + f_8 \\ g_3 = & f_3 & + f_6 & + f_9 \\ g_4 = & & & f_7 + f_8 + f_9 \\ g_5 = & & f_4 + f_5 + f_6 & \\ g_6 = f_1 + f_2 + f_3 & & & \end{cases}$$

$$\begin{bmatrix} g_1 \\ g_2 \\ g_3 \\ g_4 \\ g_5 \\ g_6 \end{bmatrix} = \begin{bmatrix} 1 & 0 & 0 & 1 & 0 & 0 & 1 & 0 & 0 \\ 0 & 1 & 0 & 0 & 1 & 0 & 0 & 1 & 0 \\ 0 & 0 & 1 & 0 & 0 & 1 & 0 & 0 & 1 \\ \hline 0 & 0 & 0 & 0 & 0 & 0 & 1 & 1 & 1 \\ 0 & 0 & 0 & 1 & 1 & 1 & 0 & 0 & 0 \\ 1 & 1 & 1 & 0 & 0 & 0 & 0 & 0 & 0 \end{bmatrix} \begin{bmatrix} f_1 \\ f_2 \\ f_3 \\ f_4 \\ f_5 \\ f_6 \\ f_7 \\ f_8 \\ f_9 \end{bmatrix}$$

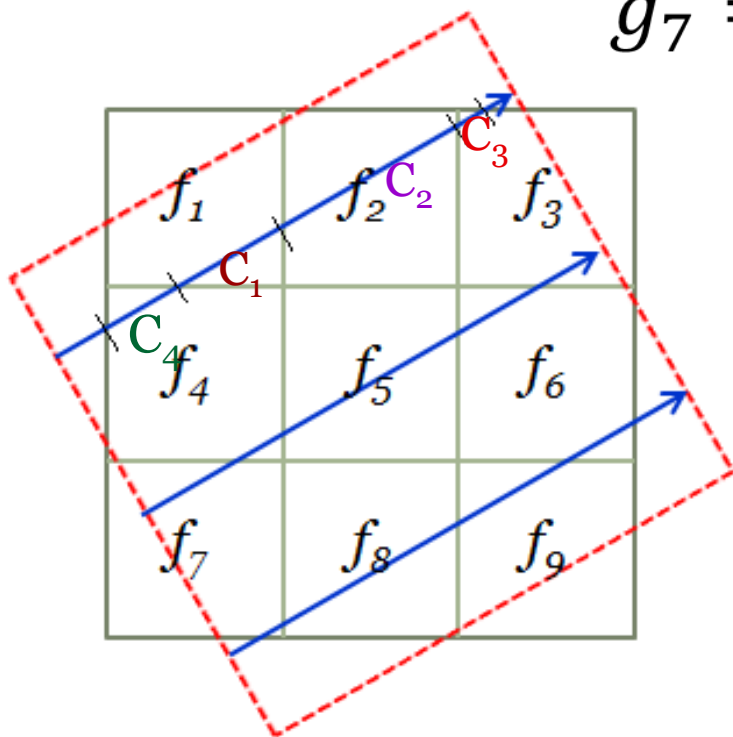
$$\underbrace{\quad}_{\mathbf{g}} \quad \underbrace{\quad}_{\mathbf{A}} \quad \underbrace{\quad}_{\mathbf{f}}$$

Projections Sparse Matrix Image

How?

Algebraic Reconstruction Technique for more than 2 projections
 Sparse matrix for more projection angles not equal to 0° and 90°

$$g_7 = C_4 f_4 + C_1 f_1 + C_2 f_2 + C_3 f_3$$



More angles \rightarrow more complicated sparse matrix

Number of rows

= length of one projection \times number of projections

Number of columns

= (length of one projection)²

How?

Interested in finding a vector solution f to the vector equation:

$$g = Af$$

unknown slice vector

Sparse matrix or
forward projection
matrix

Projection
data vector

Iterative Procedure

How?

Iteration process

$$\overline{f}_j^{(k+1)} = \frac{\overline{f}_j^{(k)}}{\sum_{i=1}^n a_{ij}} \sum_{i=1}^n \frac{g_i}{\sum_{j'=1}^m a_{ij'} \overline{f}_{j'}^{(k)}} a_{ij}$$

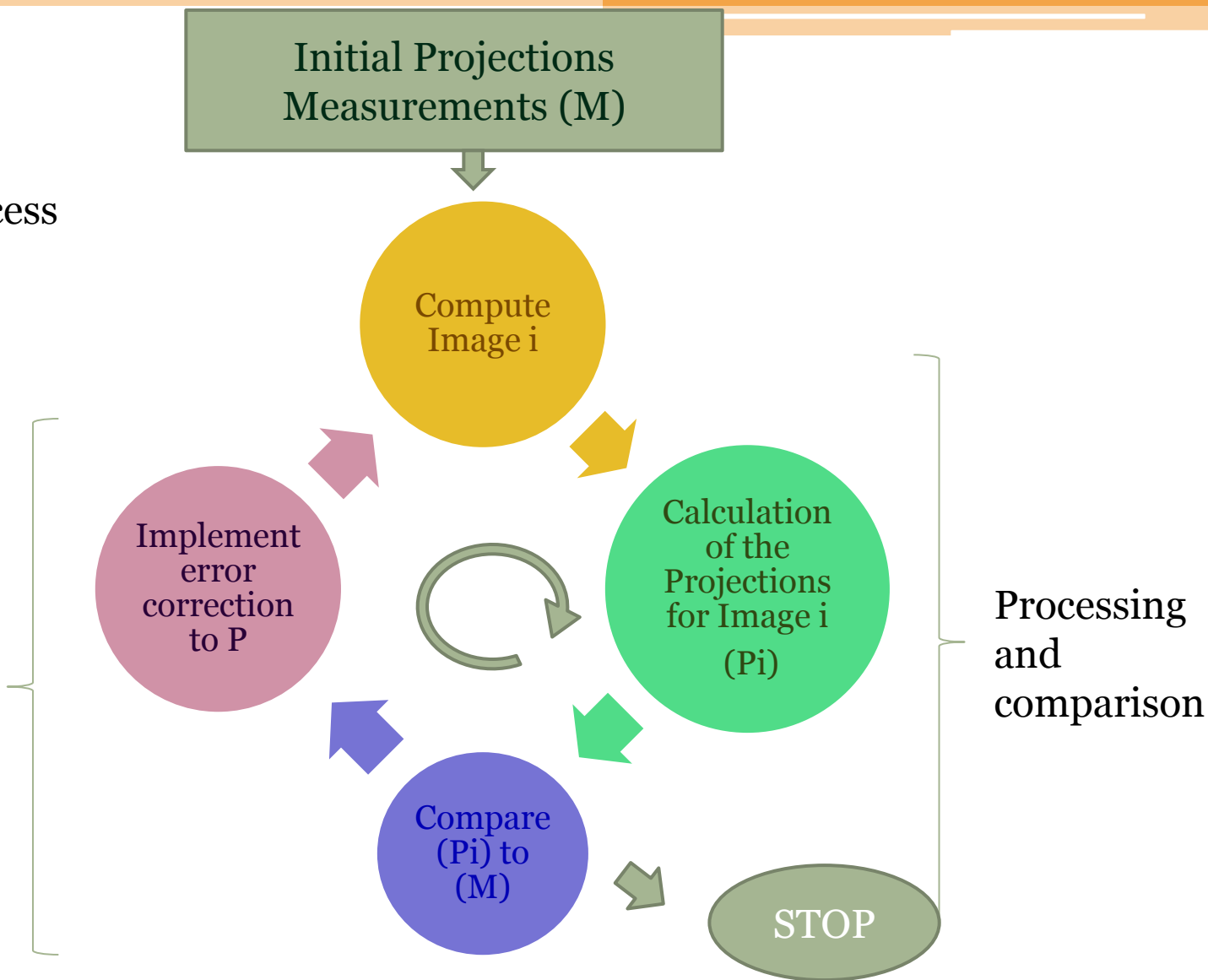
- g Vector of projection data
- f Vector of unknown slice data
- A Matrix such that $g = Af$
- a_{ij} Value of element located at the i^{th} and j^{th} column of matrix A
- i Projection subscript
- j Pixel subscript
- g_i Number of counts in the i^{th} bin of the projection dataset
- m Number of pixels
- n Number of bins

$$\text{Image}^{(k+1)} = \text{Image}^{(k)} \times \text{Normalized Backprojections of} \left(\frac{\text{Measured projections}}{\text{Projections of image}^{(k)}} \right)$$

How?

Iteration process

Reducing error
between
calculated and
initial
Measurements

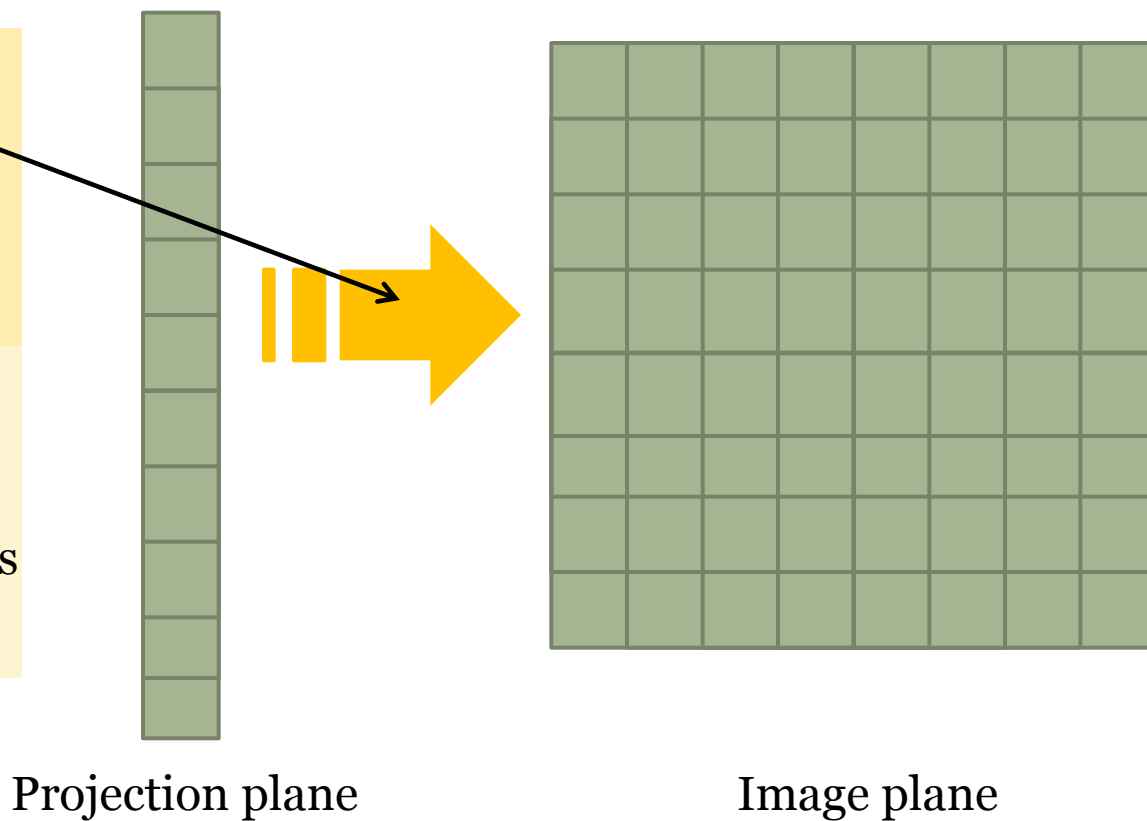


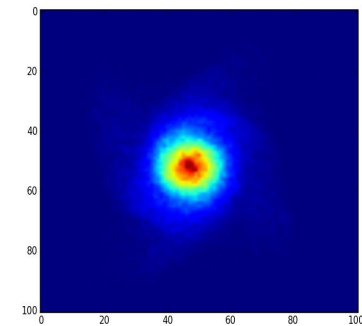
What?

Advantages of Algebraic Iterative technique:

Mathematical model that describes how the projections are obtained

- ✓ Physics of detection
- ✓ Scattering
- ✓ Pixel defects
- ✓ etc

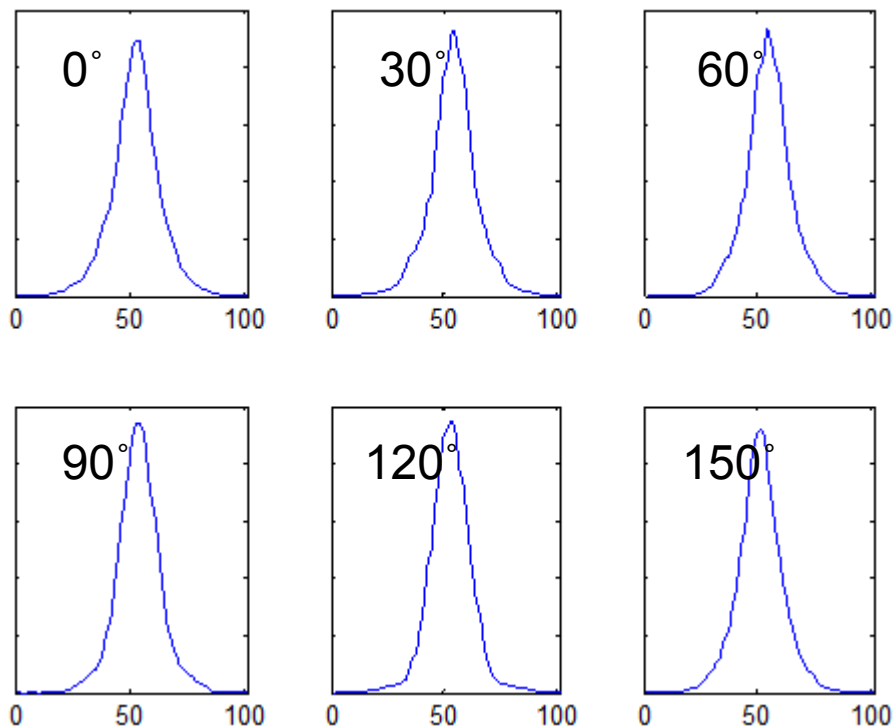




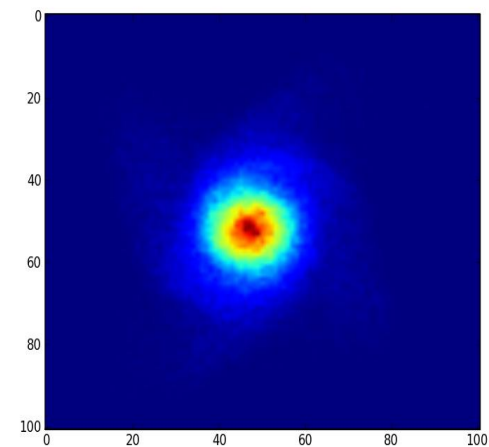
Numerical Illustration with MATLAB

Step 1

Image to Projections of the TEST IMAGE



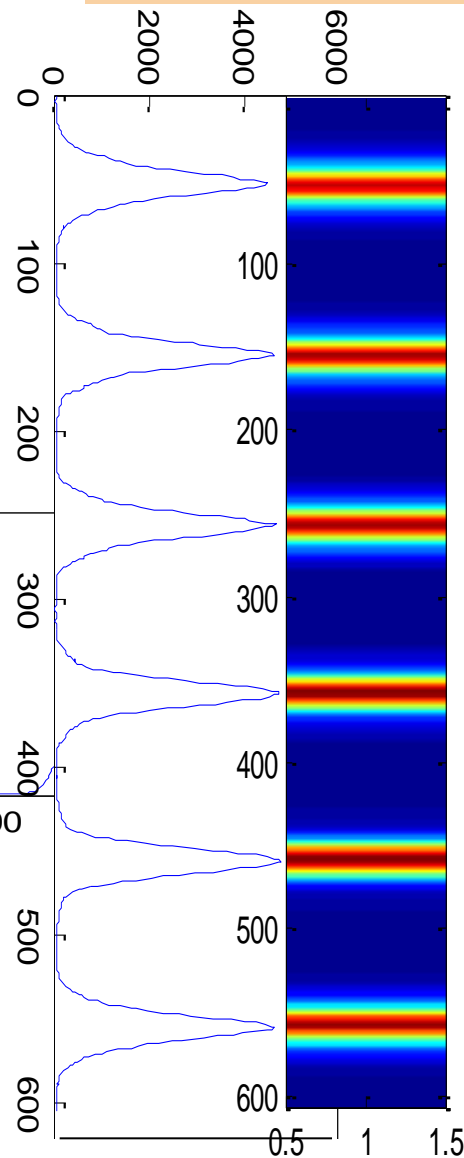
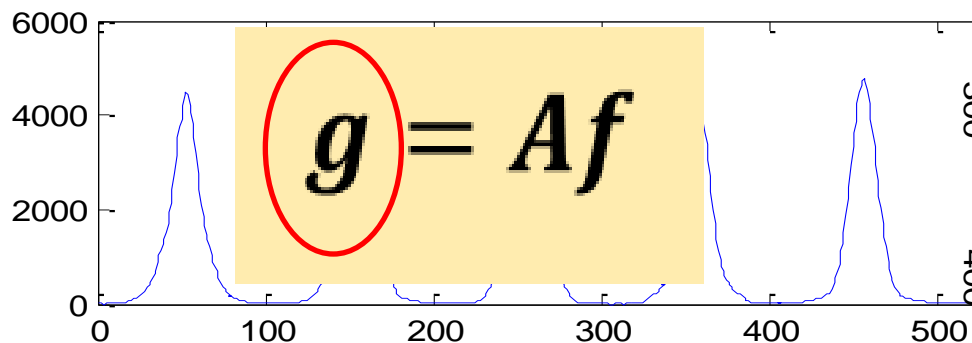
TEST IMAGE



I HAVE

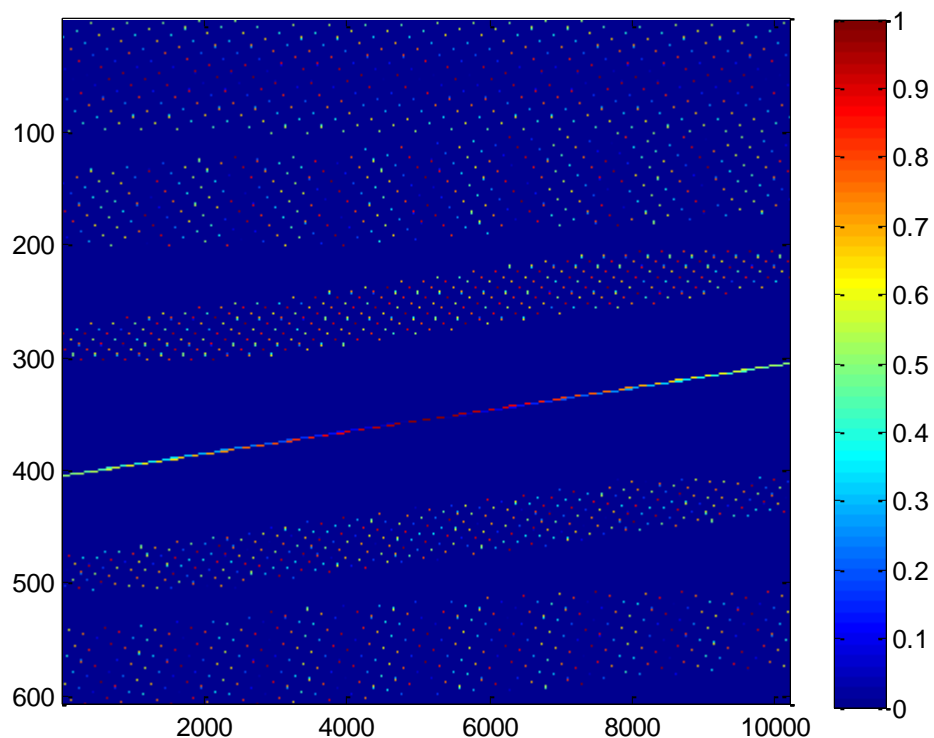
Step 2

Construction of the Projection vector " g "



Step 3

Sparse matrix is constructed



$$g = Af$$

6 projections

101 x 101 image

→ 606 x 10201 sparse matrix size

Step 5, iteration 2

f is reshaped to 101×101 image matrix

$$g = Af$$

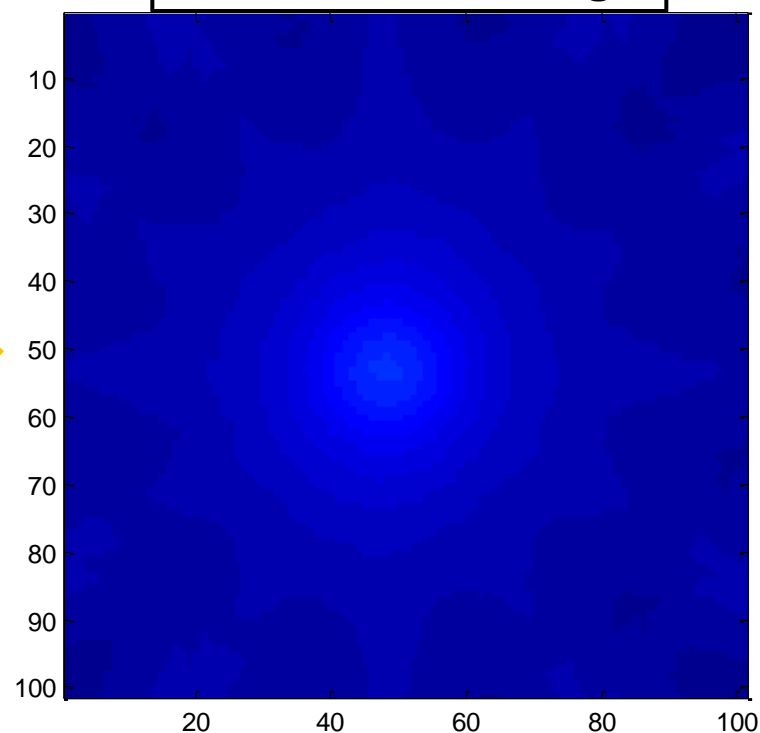
pixel values



2



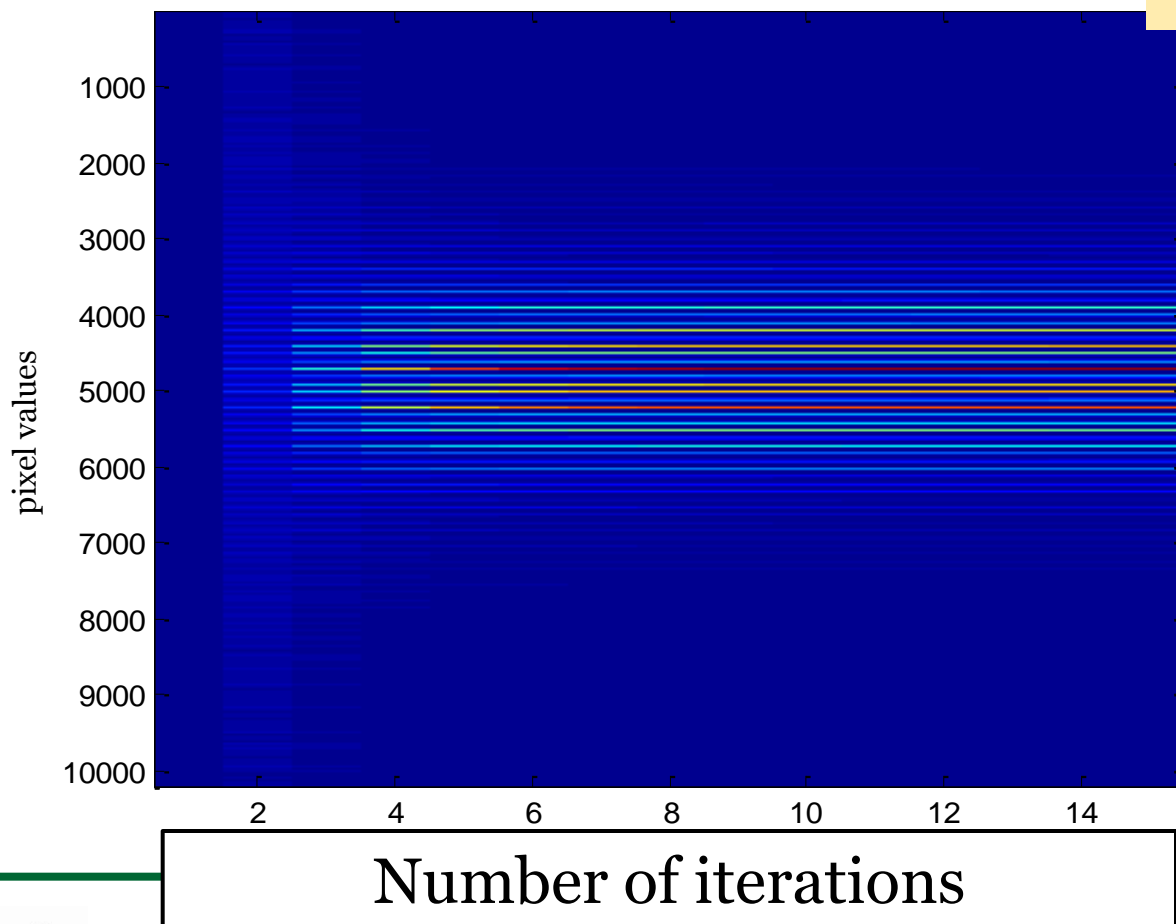
Reconstructed Image



An Illustration

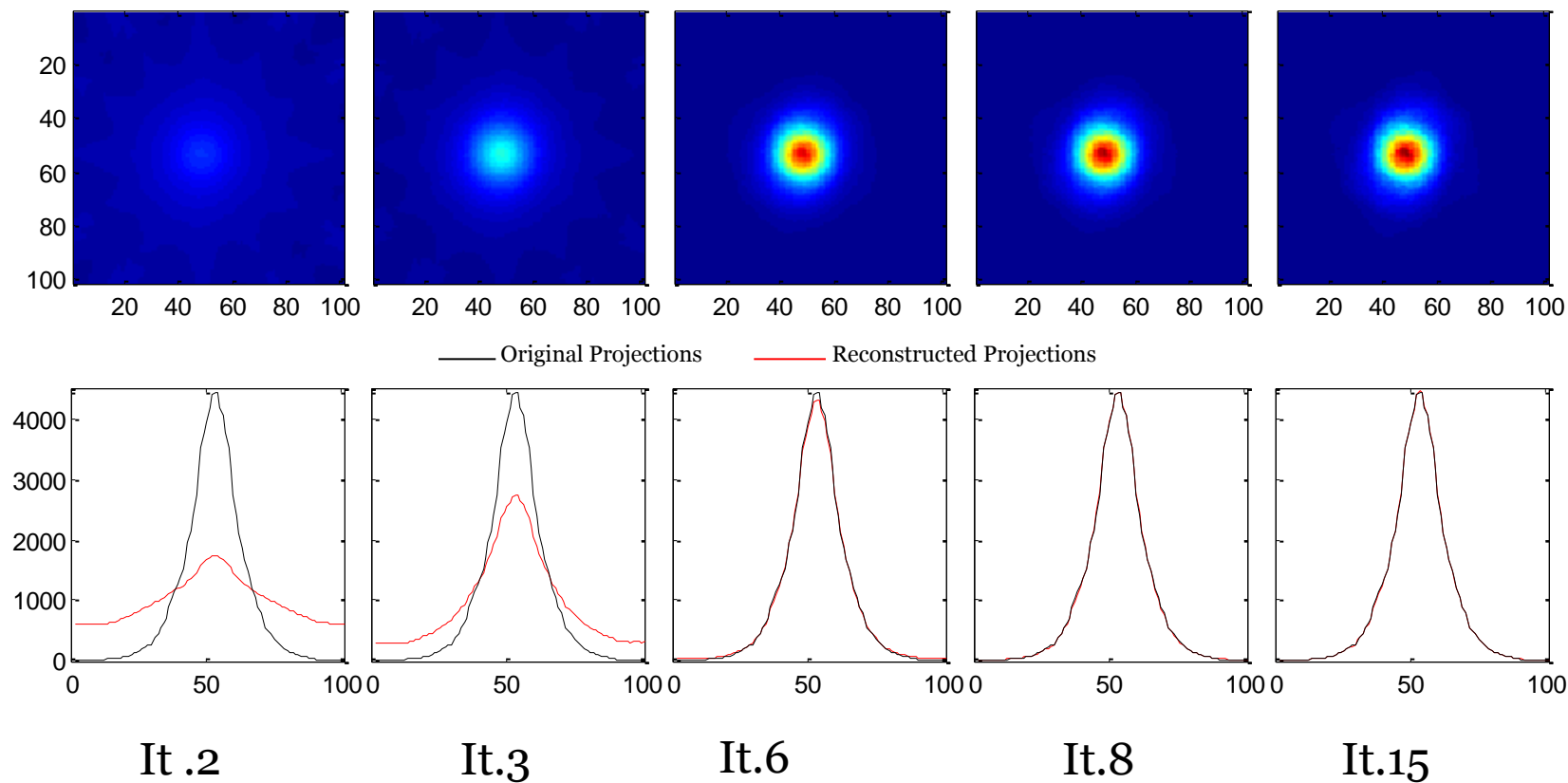
f is solved iteratively

$$g = Af$$



An Illustration

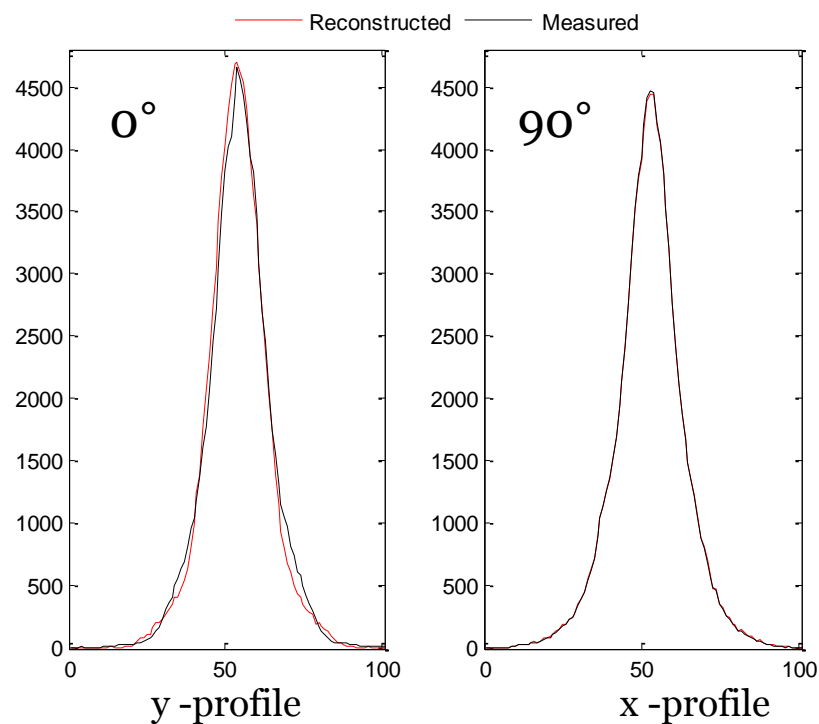
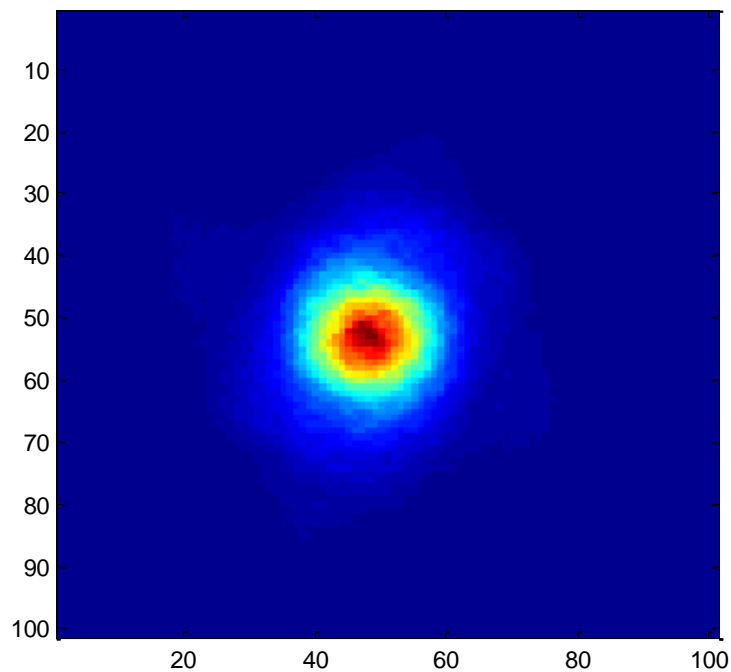
Reconstructed images with respect number of iterations



Projections measured at 90°

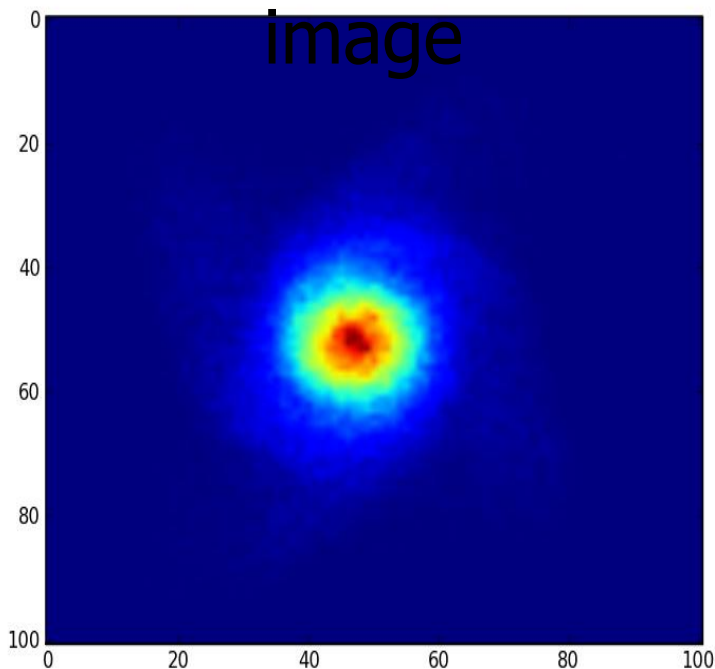
An Illustration

The reconstructed image after 15 iterations

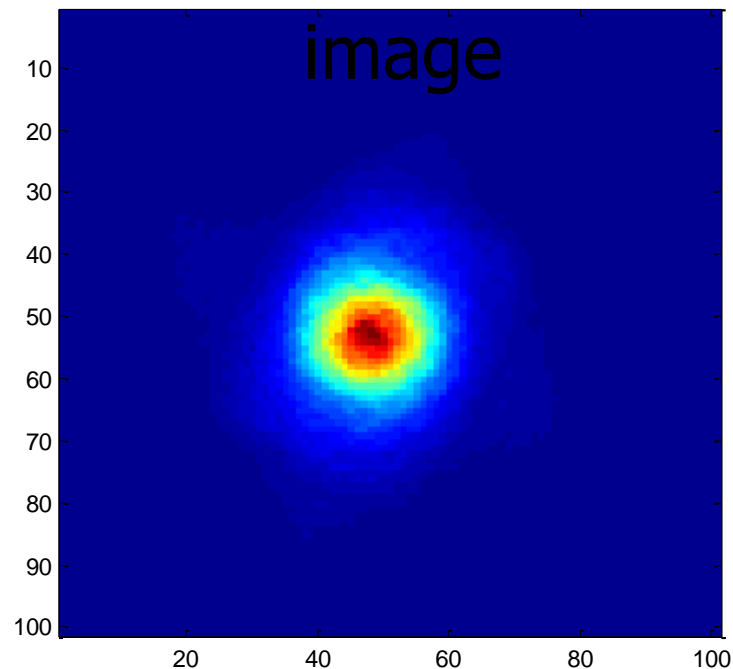


An Illustration

Original
image



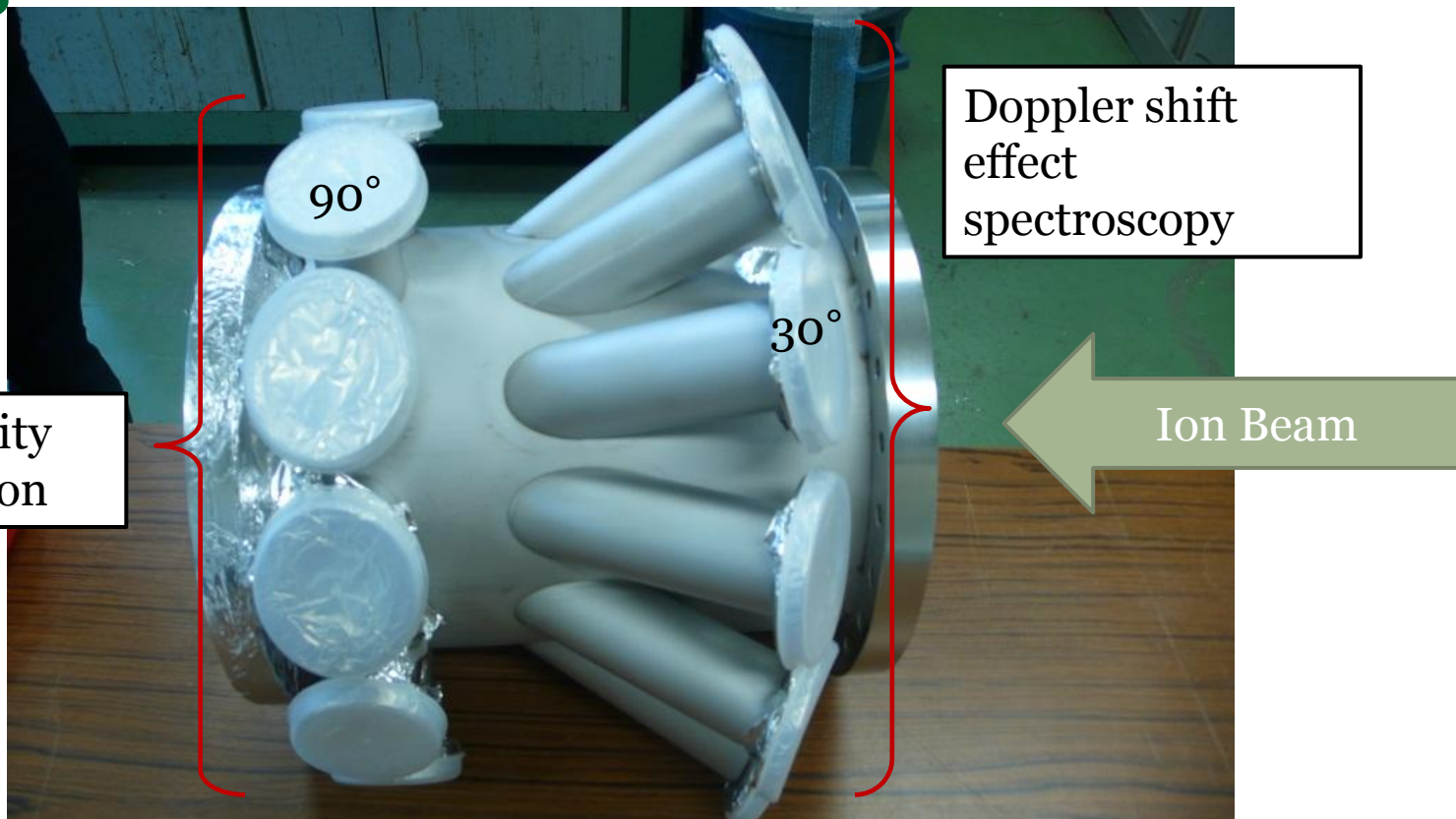
Reconstructed
image





Experimental Measurements With Ion Beams

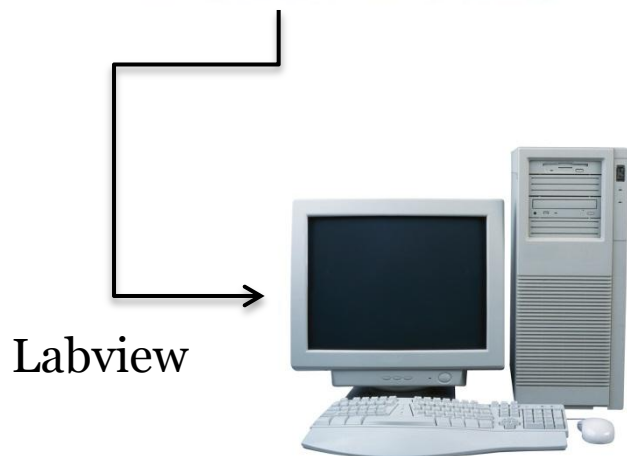
Vacuum Chamber specially designed for Measurements



Imaging and Detection



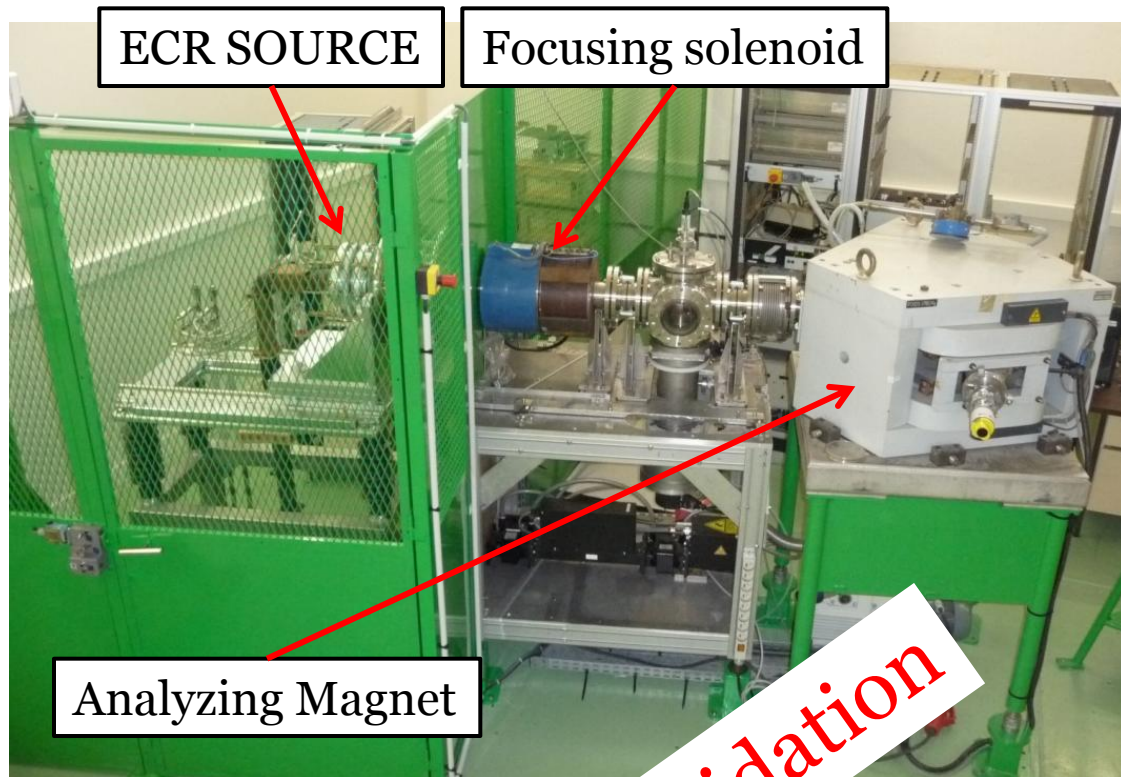
Focal Length (mm)		25
Iris Range		F1.4 ~ F16
Operation	Focus	Manual
	Iris	Manual
Angle Of View (H×V)	2/3"	19°58' × 15°02'
	1/2"	14°35' × 10°58'
	1/3"	10°58' × 8°14'
Focusing Range (From Front Of The Lens) (m)		∞ ~ 0.15
Object Dimensions at M.O.D. (H×V) (mm)	2/3"	53 × 40
	1/2"	38 × 29
	1/3"	29 × 22
Back Focal Distance (in air) (mm)		14.58
Exit Pupil Position (From Image Plane) (mm)		-32
Filter Thread (mm)		M25.5 × 0.5
Mount		C
Mass (g)		45



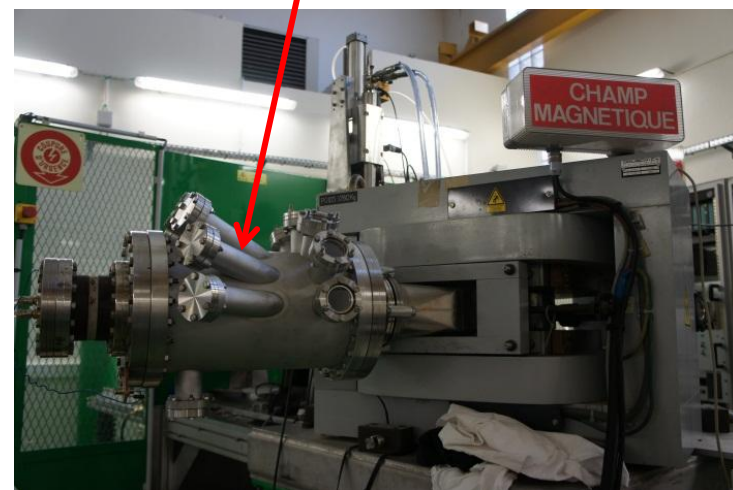
- Stingray F146B
- Fujinon HF25HA-1B objective

Measurements in BETSI test bench

Banc d'Etude et de Tests des Sources d'Ions



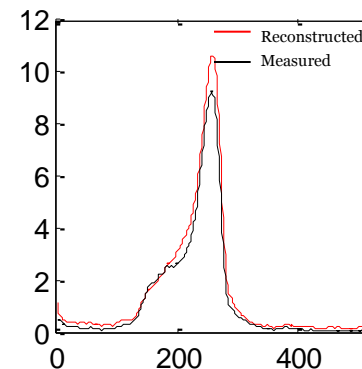
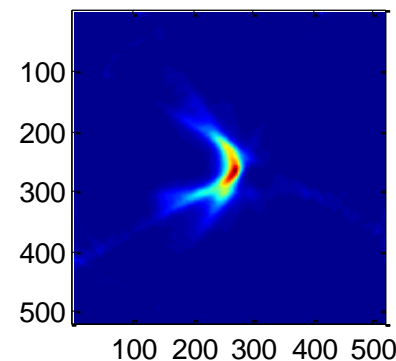
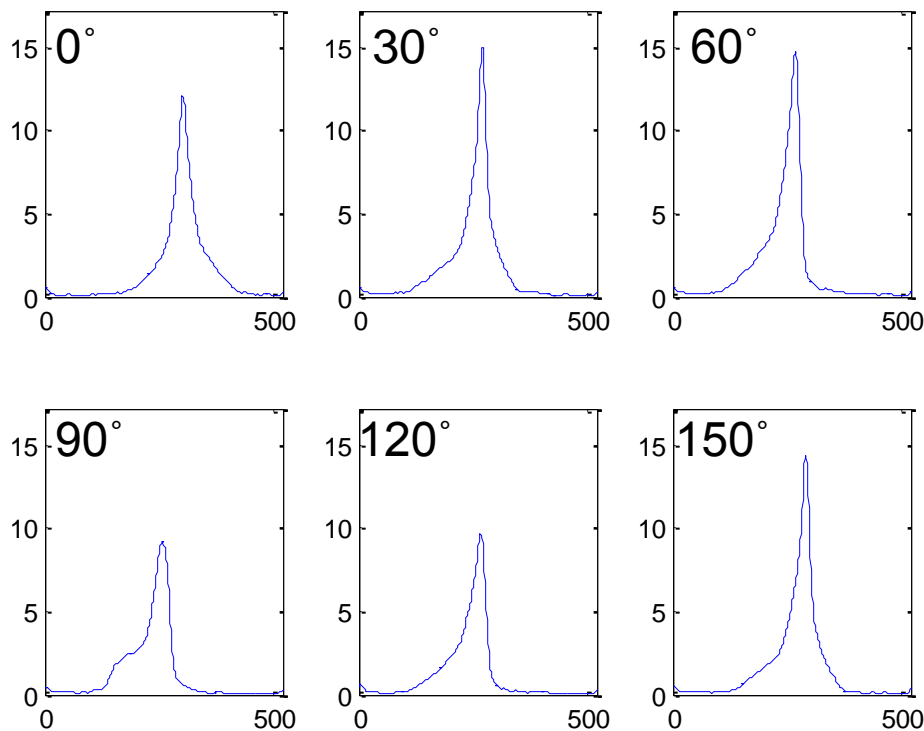
Tomographic chamber
after the Magnet



ECR source
H₂ dominated residual gas
Low Intensity beams : 2mA
H⁺ current at the beam stop

For validation

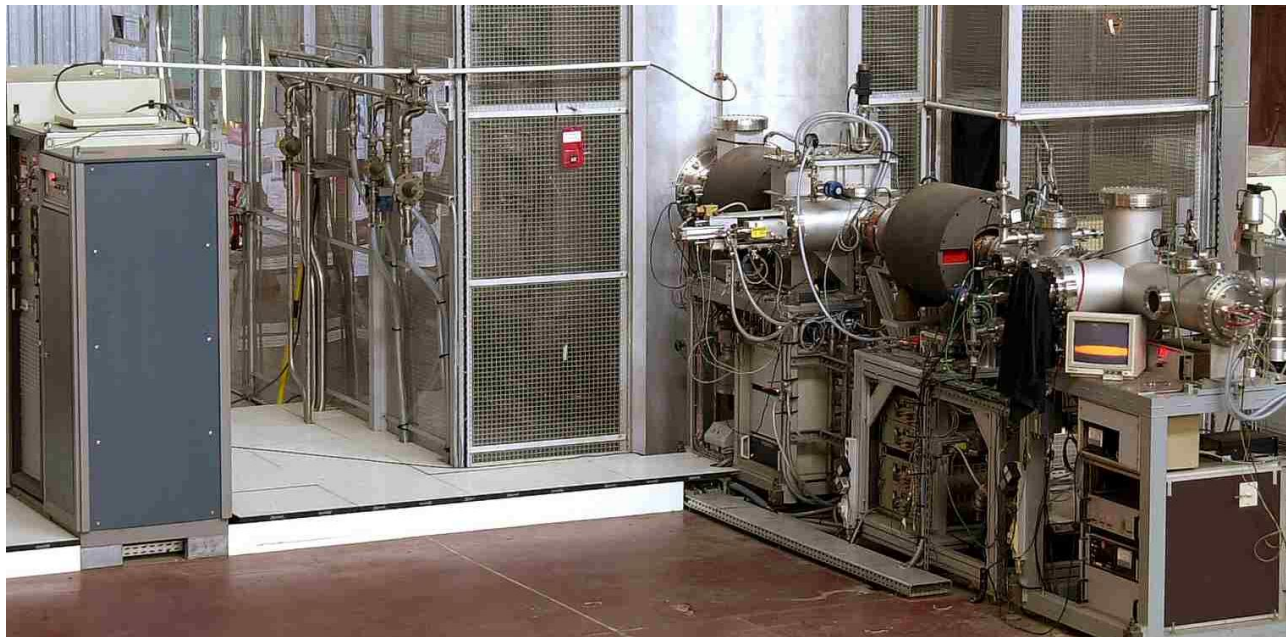
Measurements in BETSI



Bizarre "BANANA" shape beam !
NEED MORE VALIDATION

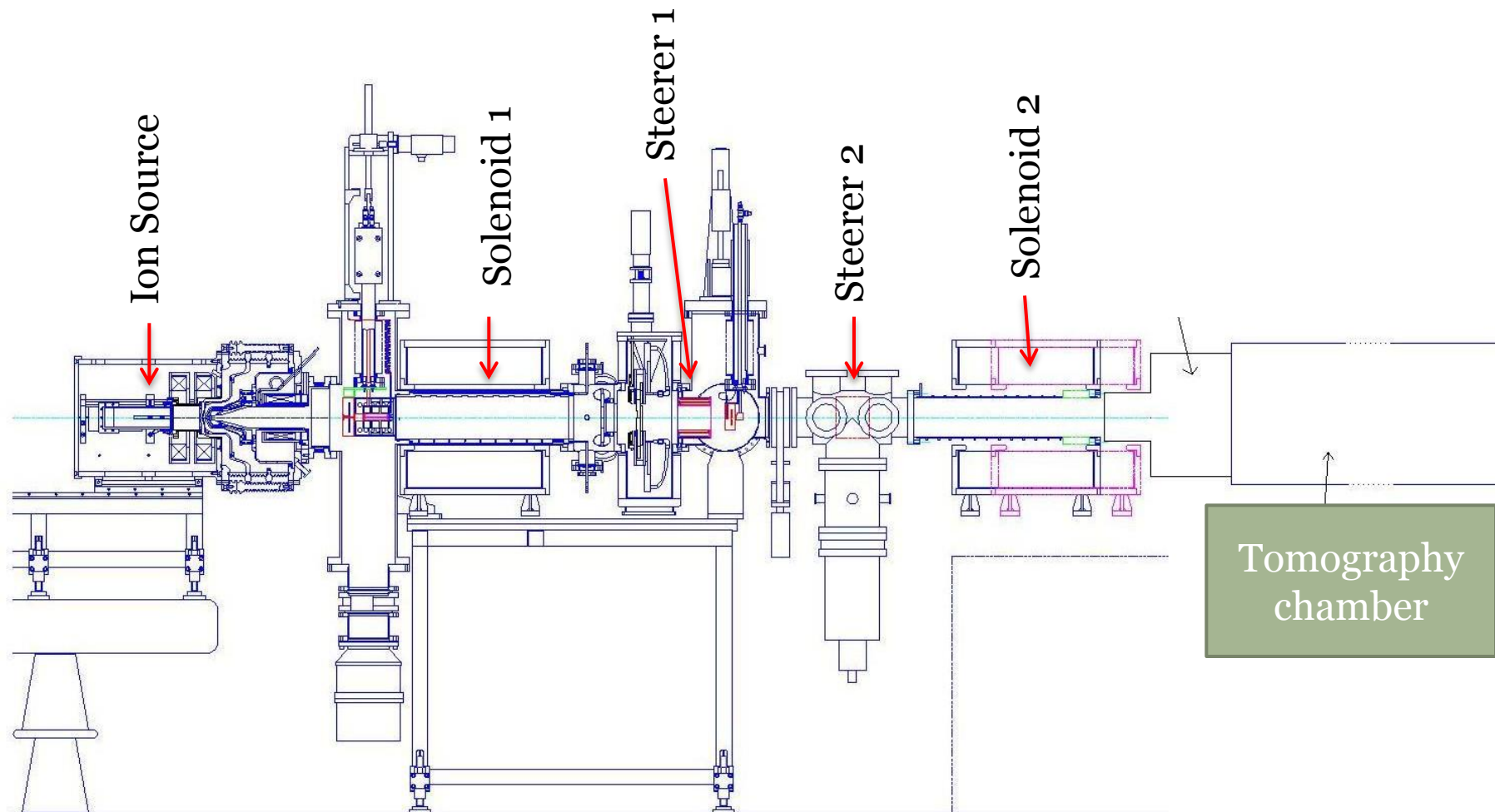
Measurements in SILHI

High Intensity Light Ion Source

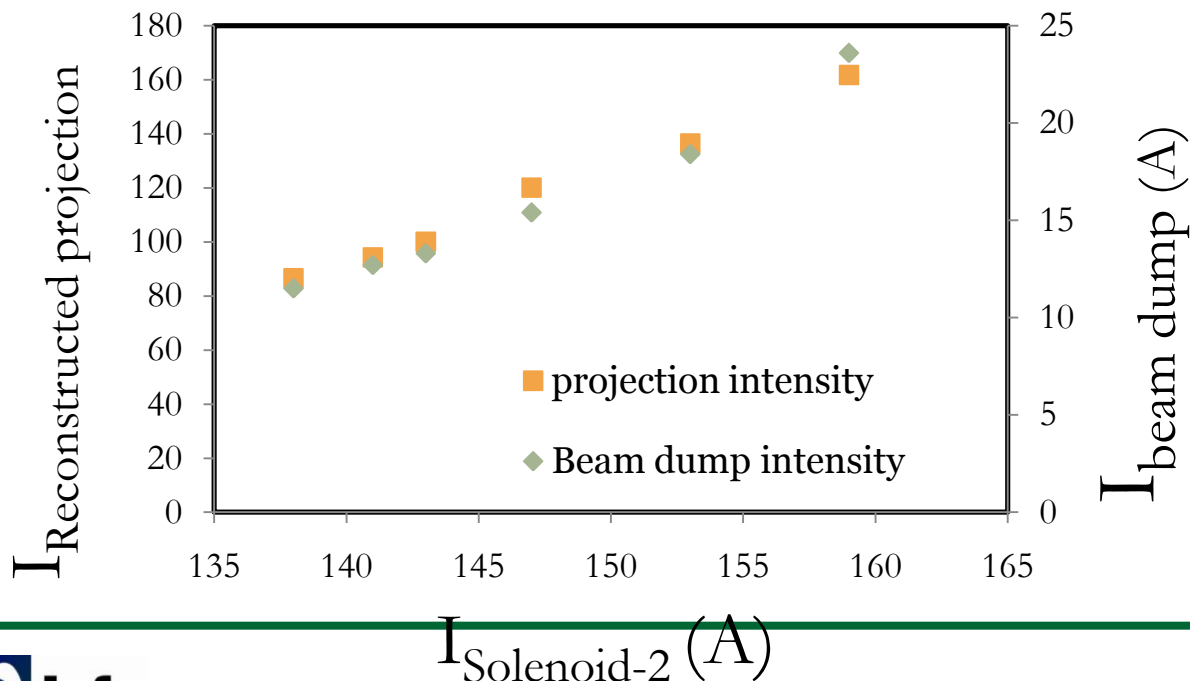
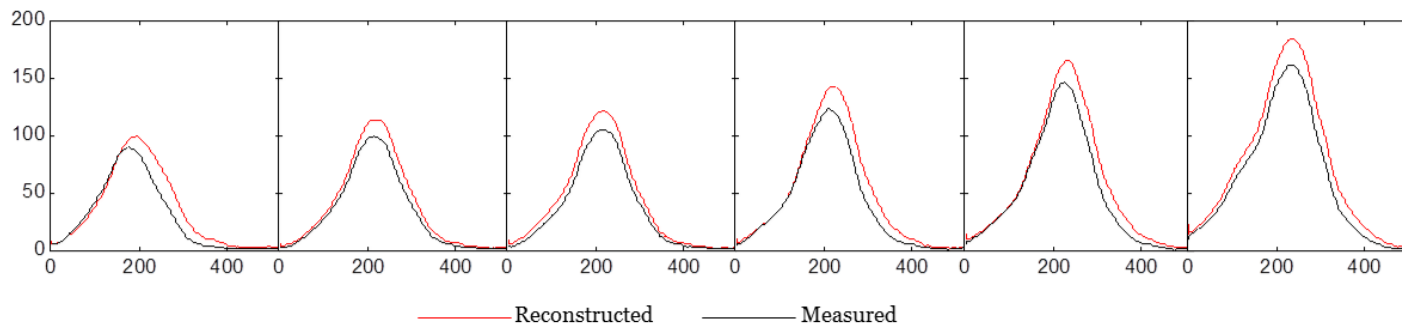


- ECRIS: 2.45 GHz - 875 Gauss.
- CW or pulsed mode.
- up to 130 mA at 95 kV → kilowatt of beam power

Measurements in SILHI

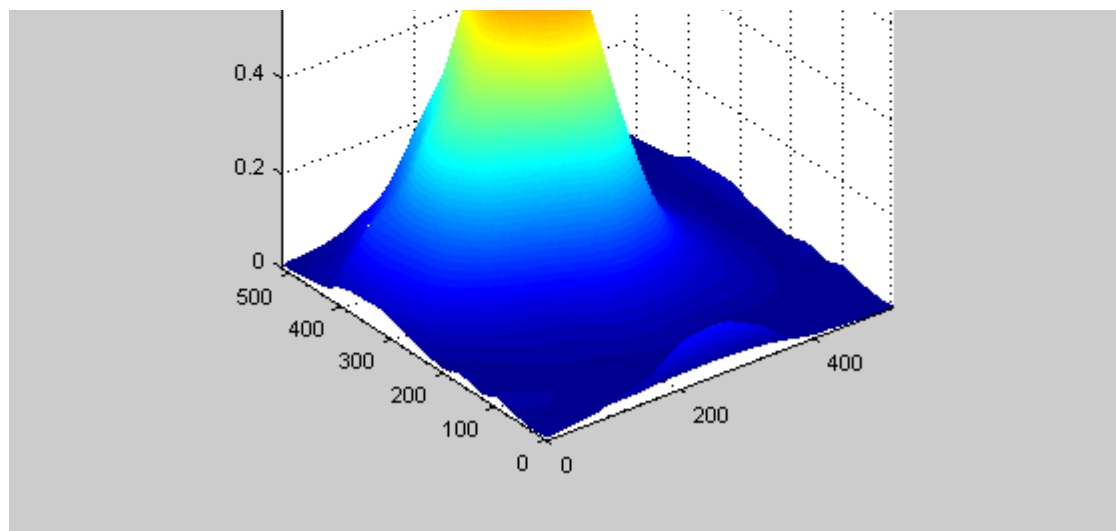
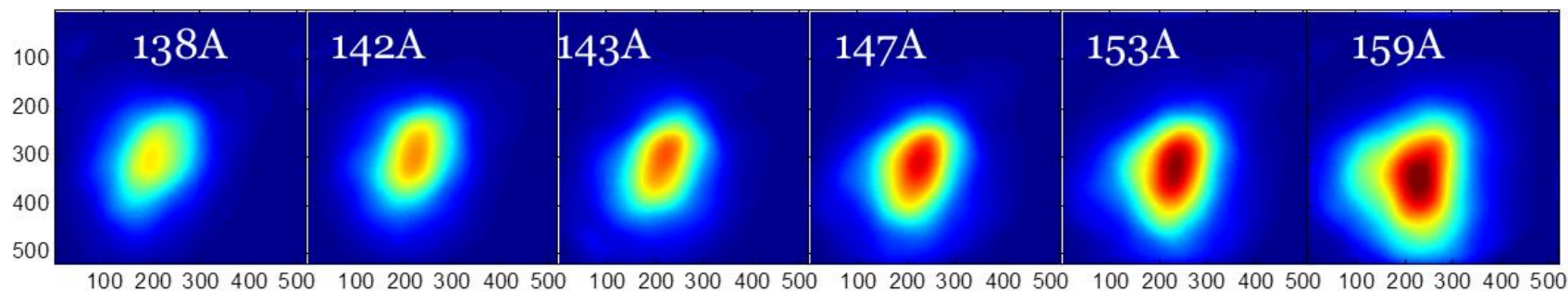


Measurements VS Sol 2 current



Same Linear dependence of the Intensity of the reconstructed projection at 90° versus the solenoid-2 current as that of the Beam intensity! ✓

Measurements VS Sol 2 current



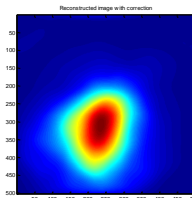
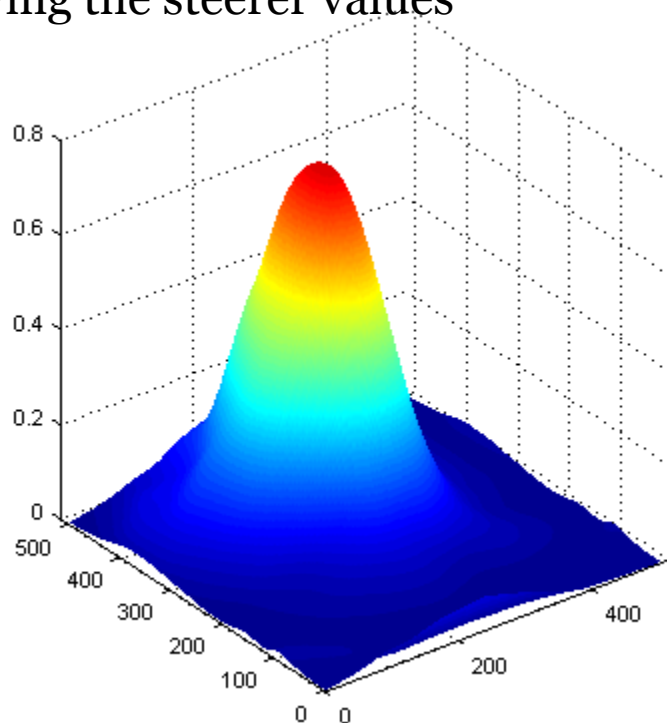
BUT
 Beam Shape
 Beam position
 have changed !

→ Non linearity of the
 solenoid for such beam size

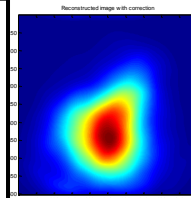
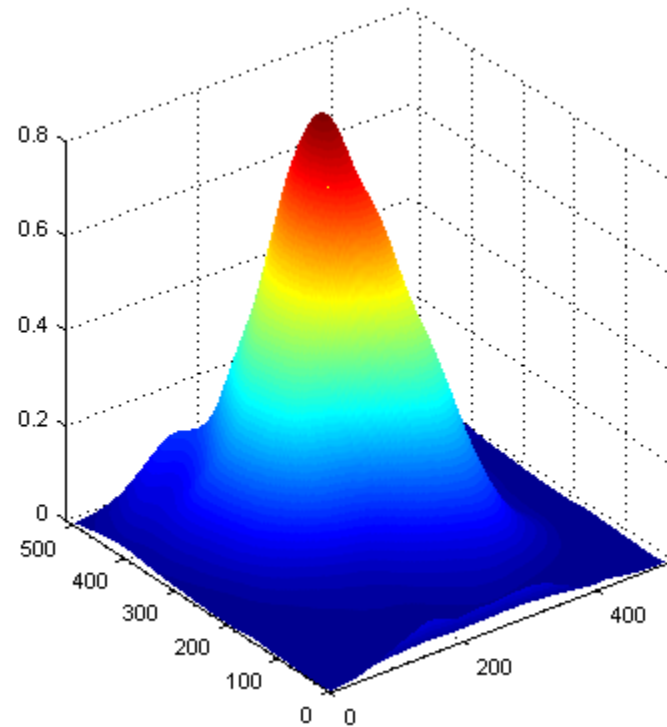
138A

Measurements VS Steerer current

Varying the steerer values

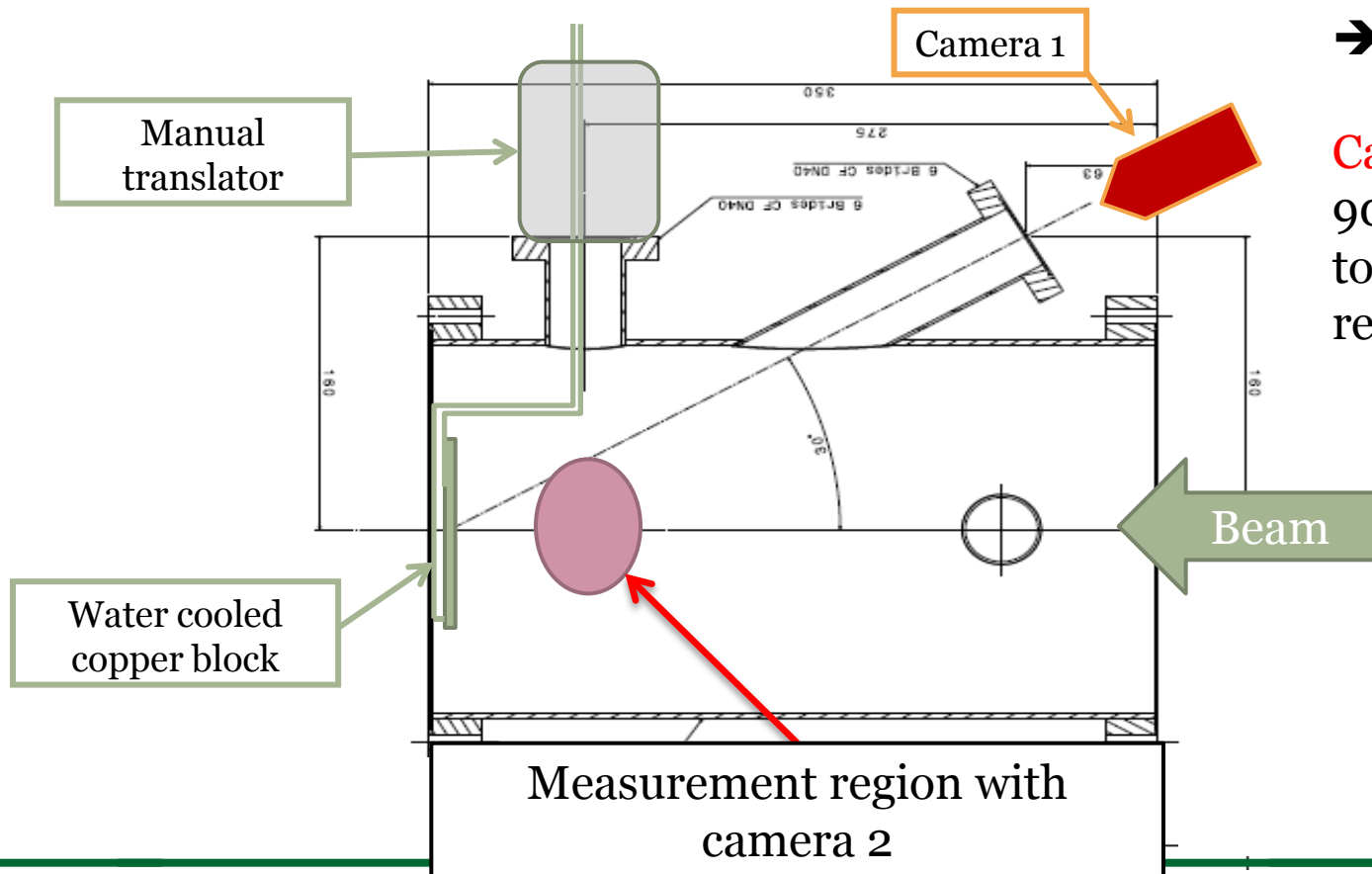


Position has changed ✓
 Intensity remains constant ✓
BUT
 Beam shape has changed !



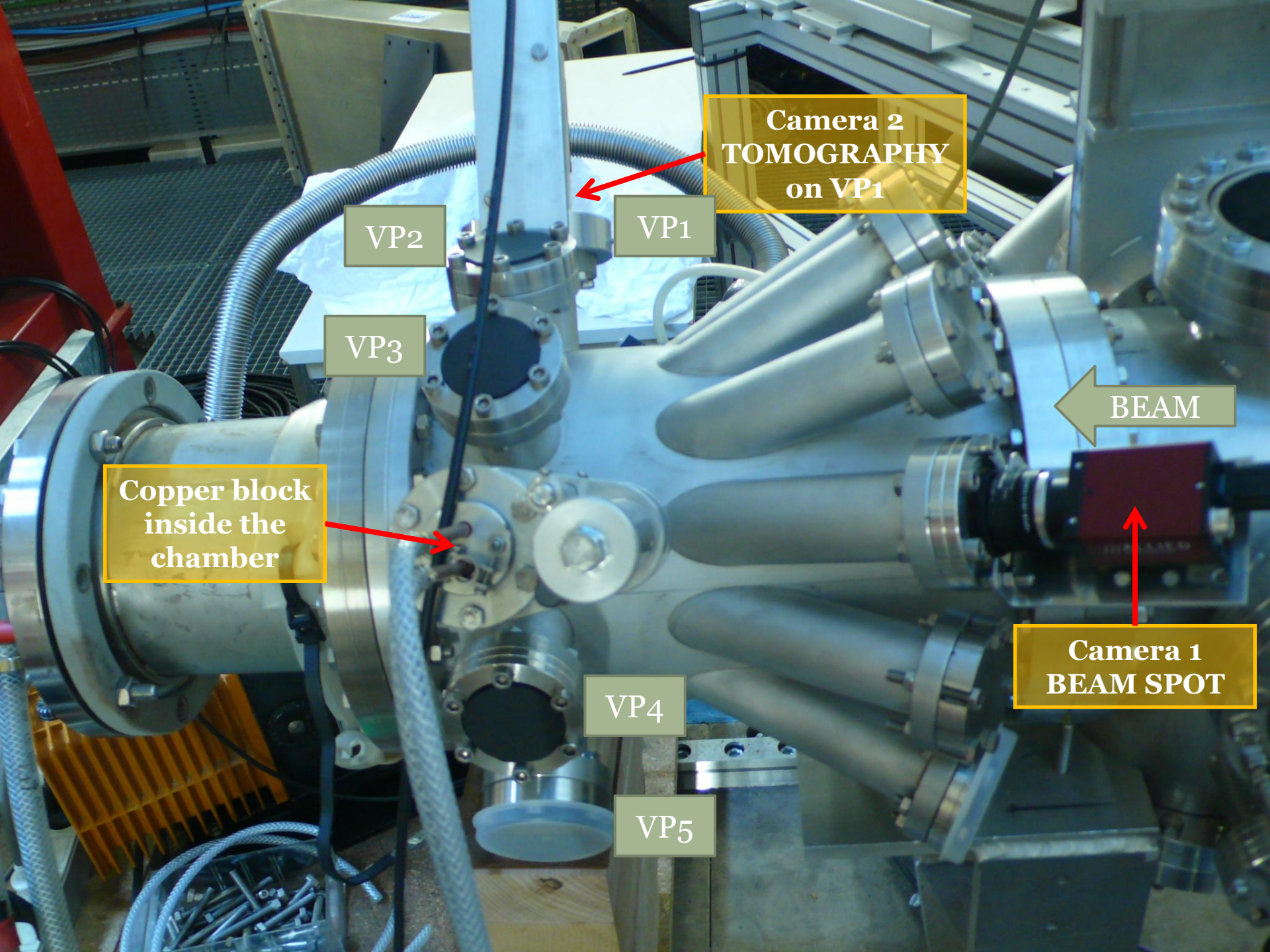
DH1 +0,2
 DV1 -0,7
 DH2 +0,5
 DV2 -0,5

Copper « Profiler »



Camera 1 for the copper « profiler » mounted on the 30° viewport
 → BEAM SPOT

Camera 2 on the five 90°-viewport for tomographic reconstruction



Camera 2
TOMOGRAPHY
on VP1

VP2

VP1

VP3

← BEAM

Copper block
inside the
chamber

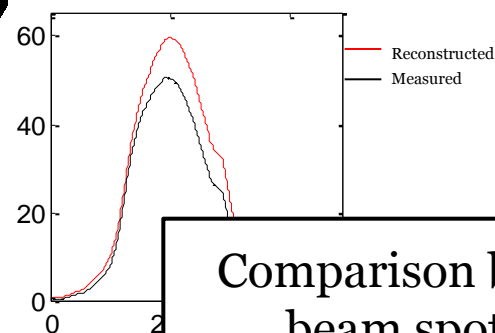
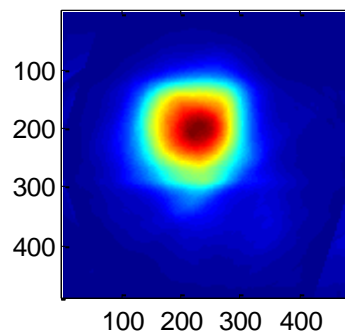
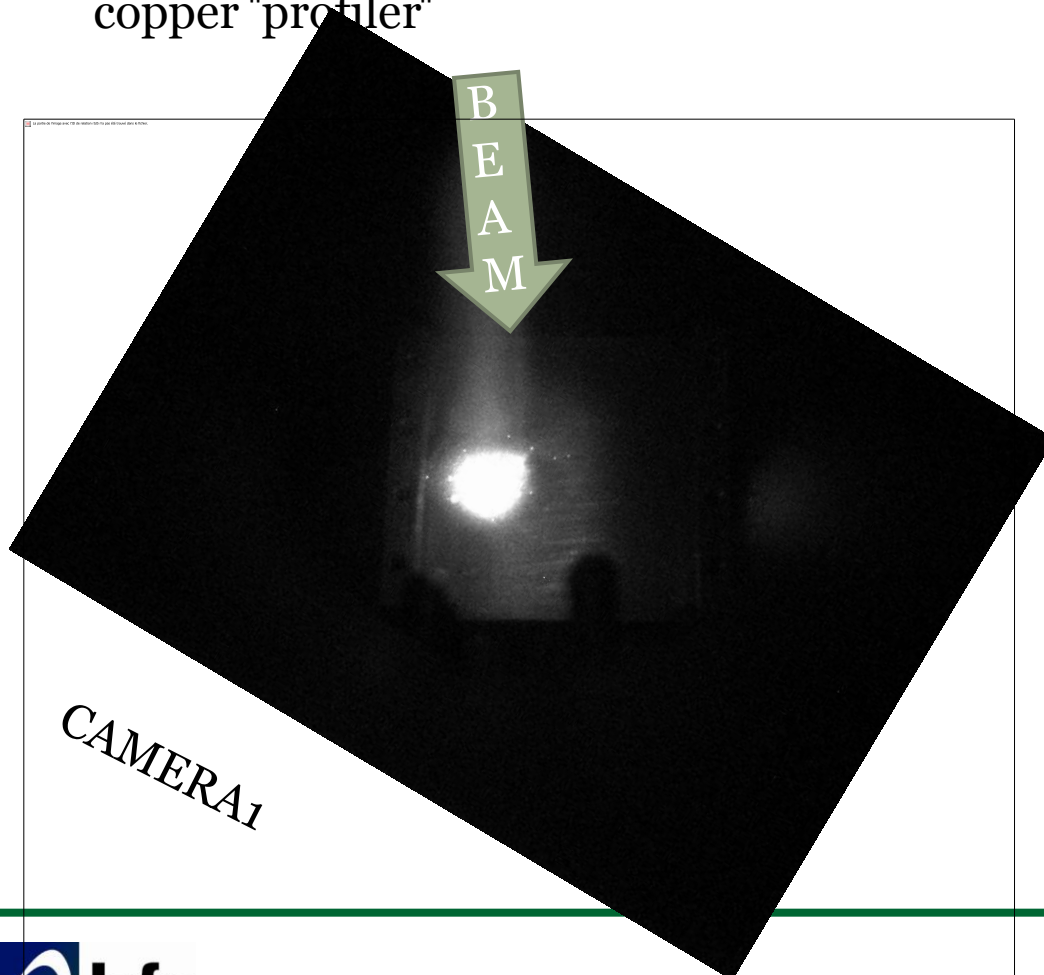
Camera 1
BEAM SPOT

VP4

VP5

Copper « Profiler »

Comparing the shape of the reconstructed image with 5 viewports with the copper "profiler"



Comparison between the beam spot and the reconstructed image shape is very much comparable even with 5 projections

Conclusion

- It was demonstrated that tomography technique can reconstruct the spatial density of the beam both for low and high intensity beams.
 - 6 viewports seemed to be enough to reconstruct smooth beams.
- The algorithm written in MATLAB is very fast.
 - Future use of 6 simultaneous cameras is foreseen.
- The accuracy of the technique has been verified by comparisons made with copper " profiler" .
 - New comparisons are expected with thermal camera
- Comparison with other algorithm is also expected.
- This algorithm should be VERY useful for the Doppler shift Technique which discriminates different species in the Beam

Acknowledgements

- This work is supported by the DITANET Marie Curie European network.
- Sincere thanks is due to the LEDA group of SACM 😊

Thank you for your attention

